

Notice of References Cited	Application/Control No. 10/809,928	Applicant(s)/Patent Under Reexamination ISEKI ET AL.	
	Examiner Rip A. Lee	Art Unit 1713	Page 1 of 1

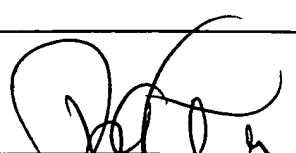
U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,995,229 B2	02-2006	Kashiwa et al.	526/348.6
*	B	US-6,914,113 B2	07-2005	McLeod et al.	526/352
*	C	US-6,706,822 B2	03-2004	Guenther et al.	525/333.7
*	D	US-6,642,339 B1	11-2003	Chai et al.	526/348.1
*	E	US-6,518,385 B1	02-2003	Chai, Choon Kooi	526/348.2
*	F	US-6,462,161 B1	10-2002	Cady et al.	526/348
*	G	US-6,420,298 B1	07-2002	Mink et al.	502/113
*	H	US-6,329,465 B1	12-2001	Takahashi et al.	525/191
*	I	US-6,225,410 B1	05-2001	Sugimura et al.	525/191
*	J	US-6,121,402 A	09-2000	Machida et al.	526/352
*	K	US-5,798,427 A	08-1998	Foster et al.	526/352
*	L	US-5,747,620 A	05-1998	Machida et al.	526/348.3
*	M	US-5,710,224 A	01-1998	Alt et al.	526/160

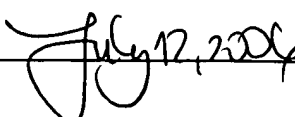
FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

 July 12, 2006